Binomial Regression II

Reminder: questions from Challenger disaster

- Forecast probability of an O-ring being damaged when the launch temperature is 29 °F.
- How good is our forecast? Can we provide a confidence interval?
- Is temperature useful to predict the O-ring failing?

Is temperature useful to predict the O-ring failing?

 Y_i , the number of damaged O-rings on the i-th launch, has distribution

$$Y_i \sim \mathsf{bin}(6, p_i)$$

where

$$\log p_i/(1-p_i)=\eta_i=\beta_0+\beta_1t_i.$$

Test for association between the number of damaged O-rings and temperature:

$$H_0: \beta_1 = 0 \quad H_a: \beta_1 \neq 0$$

- Wald Test
- Likelihood Ratio Test

Wald Test

Reminder: asymptotic normality of MLE

$$\hat{ heta}_i \sim$$
 asy. $extstyle{\mathsf{N}}(heta_i^*, [\mathcal{I}(\hat{oldsymbol{ heta}})^{-1}]_{i,i})$

e normality of MLE
$$\hat{\theta}_i \sim \text{asy. } N(\theta_i^*, [\mathcal{I}(\hat{\theta})^{-1}]_{i,i}).$$

Test for association between the number of damaged O-rings and

temperature

$$H_0: \beta_1 = 0 \quad H_a: \beta_1 \neq 0$$

Wald test statistic:

stic:
$$z^* = \frac{\hat{\beta_1}}{se(\hat{\beta_1})} \sim asy. \ N(0,1) \ under \ H_0.$$

Challenger disaster

- See R script and result in "Wald Test" of Challenger.pdf
- $|z^*| = 4.07 > 1.96$ (critical value N(0,1) at $\alpha = 0.05$) \Rightarrow reject H_0 .
- p-value = 0.0000476.



Likelihood Ratio Test (LRT)

Test for association between the number of damaged O-rings and temperature

$$H_0: \beta_1 = 0 \quad H_a: \beta_1 \neq 0$$

Full model (F):

- \bullet $\eta_i = \beta_0 + \beta_1 t_i$
- Maximum log likelihood: $\log \mathcal{L}(\hat{\boldsymbol{\beta}}^F)$
- $\hat{\beta}^{F}$: MLE of the parameters in the full model.

Reduced model (R): model under Ho

- \bullet $\eta_i = \beta_0$
- Maximum log likelihood: $\log \mathcal{L}(\hat{\boldsymbol{\beta}}^R)$
- $\hat{\beta}^R$: MLE of the parameters in the reduced model. Compare two models.
- Likelihood ratio test statistic:

• $LR^*>$ critical value from χ_1^2 at $\alpha\Rightarrow$ reject H_0 .

elihood ratio test statistic:
$$LR^* = -2 \left[\log \mathcal{L}(\hat{\boldsymbol{\beta}}^R) - \log \mathcal{L}(\hat{\boldsymbol{\beta}}^F) \right] \sim \text{asy. } \chi_1^2 \text{ under } H_0. \text{ but model}$$
 full: for k fill:

intuition : model with more parameters nid have a high litelihood.

if full model include useful parameters, then 1991 (it not increase a cot,

1: difference in the number of LR* is large parameters between full and

Wald test vs Likelihood Ratio Test (LRT)

Wald test and LRT are asymptotically equivalent.

$$[z^*]^2 = \left[\frac{\hat{eta}_1}{se(\hat{eta}_1)}\right]^2 \sim asy. \ \chi_1^2$$

• Precisely speaking, two tests are asymptotically equivalent in the sense that under H_0 they reach the same decision with probability approaching 1 as n goes to infinite.

However, the chi-squared approximation to the log likelihood ratio is generally better than the normal approximation to the MLE.

Likelihood Ratio Test (LRT): Challenger disaster

- See R script and result in "Likelihood Ratio test" and "Wald Test vs Likelihood Ratio test" of Challenger.pdf
- $LR^* = 21.98 > 3.84$ (critical value from χ_1^2 at $\alpha = 0.05$) \Rightarrow reject H_0 .
- p-value = 0.0000027.

model & V Nested Model models (one model can be obtained by constraining parameters of another

model \mathcal{N} wester Maximum log likelihood: $\log \mathcal{L}(\hat{\boldsymbol{\theta}}^F)$

Reduced model (R):

yie hot protest protest to the number of parameters between two models.

Let k indicate the difference in the number of parameters between two models.

Compare two nested models.

Under the reduced model $LR^* = -2 \left[\log \mathcal{L}(\hat{\boldsymbol{\theta}}^R) - \log \mathcal{L}(\hat{\boldsymbol{\theta}}^F) \right] \qquad 2$

$$LR^* = -2\left[\log\mathcal{L}(\hat{oldsymbol{ heta}}^R) - \log\mathcal{L}(\hat{oldsymbol{ heta}}^F)
ight] \sim \textit{asy. } \chi_k^2$$

• $LR^* > \text{critical value from } \chi_k^2 \text{ at } \alpha \Rightarrow \text{select the full model.}$

we know: but is the model con.

Good enough

Full mo Maximum log linguage of the fitted Reduced model (R):

The fitted model

(Scaled) Deviance

The scaled deviance is used to judge model adequacy.

For the binomial regression model the deviance is the same as the scaled deviance, which is defined as the log likelihood ratio for the fitted model compared to the saturated model

Full model (F):

of parameter = H of observation

- The saturated model has the same number of parameters and the observations.
- Maximum log likelihood: $\log \mathcal{L}(\hat{\boldsymbol{\theta}}^F)$
- The fitted model.
- Maximum log likelihood: $\log \mathcal{L}(\hat{\boldsymbol{\theta}}^R)$

The scaled deviance:

if D too big, means we wish lots of info

$$D = -2 \left[\log \mathcal{L}(\hat{\boldsymbol{\theta}}^R) - \log \mathcal{L}(\hat{\boldsymbol{\theta}}^F) \right].$$

Binomial Regression II 9/17 (Scaled) Deviance

Warning: the number of parameters in the saturated model is n, which is not fixed, so the theory of maximum likelihood does not apply, and D may not converge to a chi-squared distribution.

but for binomial regression, still can use the log-vitelihood chi-squared approximation to the log-vitelihood rottil

(Scaled) Deviance for binomial regression model

The saturated model allows for one parameter for each observation. For binomial regression the saturated model has p_1, p_2, \ldots, p_n as parameters. Clearly, for this model we estimate p_i by y_i/m_i . Let $\hat{p}_i = g^{-1}(x_i^T \hat{\beta})$ be our (not saturated) model estimate of p_i , then the scaled deviance is

fitted

$$D = -2 \sum_{i=1}^{n} \left(y_{i} (\log \hat{p}_{i} + (m-y_{i})) \log (1-\hat{p}_{i}) \right) + (m_{i} - y_{i}) (\log (1-\hat{p}_{i}) - \log (1-\frac{y_{i}}{m_{i}}))$$

$$= -2 \sum_{i=1}^{n} \left(y_{i} (\log \hat{p}_{i} - \log \frac{y_{i}}{m_{i}}) + (m_{i} - y_{i}) (\log (1-\hat{p}_{i}) - \log (1-\frac{y_{i}}{m_{i}})) \right)$$

$$= -2 \sum_{i=1}^{n} \left(y_{i} \log \frac{\hat{y}_{i}}{y_{i}} + (m_{i} - y_{i}) \log \frac{m_{i} - \hat{y}_{i}}{m_{i} - y_{i}} \right)$$

where $\hat{y}_i = m_i \hat{p}_i$ is the *i*-th fitted value.

(Scaled) Deviance for binomial regression model for testing model adequacy

It just happens: if $m_i p_i$ and $m_i (1 - p_i)$ are large enough (≥ 5 is a common rule of thumb), then for a binomial regression model, if the model is adequate then $D \approx \chi^2_{n-k}$, where k is the number of parameters in the fitted model (including β_0).

In this case the (scaled) deviance can be used as a test for model adequacy. If D is too large (as compared to a χ^2_{n-k}), then the model is missing something.

For a binomial model with small m_i we can't use the (scaled) deviance directly to test model adequacy, but we can still use it for model selection.



Use the scaled deviance for model selection (LRT)

If model A is nested within model B, and model A has (scaled) deviance D^A and model B has (scaled) deviance D^B , then

$$D^{A} - D^{B} = -2 \left[\log \mathcal{L}(\hat{\boldsymbol{\theta}}^{A}) - \log \mathcal{L}(\hat{\boldsymbol{\theta}}^{B}) \right],$$

where $\hat{\boldsymbol{\theta}}^A$ and $\hat{\boldsymbol{\theta}}^B$ are MLEs for the models A and B, respectively.

That is, the log likelihood for the saturated model cancels, and we are left with the log likelihood ratio.

 $\nabla^{A} = -2 \left[\log L(\hat{o}^{A}) - (\log L(\hat{s}) \right]$ $\nabla^{B} = -2 \left[(\log L(\hat{o}^{B}) - (\log L(\hat{s})) \right]$ $\nabla^{A} = -2 \left[(\log L(\hat{o}^{B}) - (\log L(\hat{s})) \right]$ $\nabla^{A} = -2 \left[\log L(\hat{o}^{A}) - (\log L(\hat{s}) \right]$

Use the scaled deviance for model selection (AIC)

The Akaike Information Criterion is used for model selection:

$$\mathsf{AIC} = 2k - 2\log\mathcal{L}(\hat{\boldsymbol{\theta}})$$

where k is the number of parameters in the model. Given a choice, we prefer that model with the smaller AIC.

If model B has s more parameters than model A (not necessarily nested within B), then

$$AIC^{B} - AIC^{A} = 2s - 2\log \mathcal{L}(\hat{\boldsymbol{\theta}}^{B}) + 2\log \mathcal{L}(\hat{\boldsymbol{\theta}}^{A})$$
$$= 2s - D^{A} + D^{B}.$$

Binomial Regression II

(Scaled) deviance: Challenger disaster

• See R script and result in "Deviance" of Challenger.pdf

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Learning goals

Understand binomial regression

- know when you should use binormal regression.
- be able to write binomial regression model and its likelihood.
- be able to obtain estimators of parameters or function of parameters using R script.
- be able to quantify uncertainty of the estimators (e.g., computing CI).
- be able to test hypothesis.
- be able to do model selection.

Understand asymptotic properties of MLEs (maximum likelihood estimators)

• use asymptotic normality of MLEs to quantify uncertainty of the estimators (e.g., Wald CI).

Undertand Wald test and likelihood ratio test (LRT)

• use them to test hypothesis in binomial regression

Understand (scaled) deviance

• use it to test model adequacy or perform LRT and model comparison.